



New Product

**Si4340DY**  
Vishay Siliconix

## Dual N-Channel 20-V (D-S) MOSFET with Schottky Diode

PRODUCT SUMMARY			
	V <sub>DS</sub> (V)	r <sub>DS(on)</sub> (Ω)	I <sub>D</sub> (A)
Channel-1	20	0.012 @ V <sub>GS</sub> = 10 V	9.6
		0.0175 @ V <sub>GS</sub> = 4.5 V	7.8
0.010 @ V <sub>GS</sub> = 10 V		13.5	
0.0115 @ V <sub>GS</sub> = 4.5 V		12.8	
Channel-2			

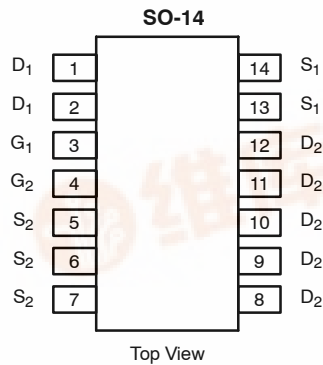
SCHOTTKY PRODUCT SUMMARY		
V <sub>DS</sub> (V)	V <sub>SD</sub> (V) Diode Forward Voltage	I <sub>F</sub> (A)
20	0.53 V @ 3 A	2.0

### FEATURES

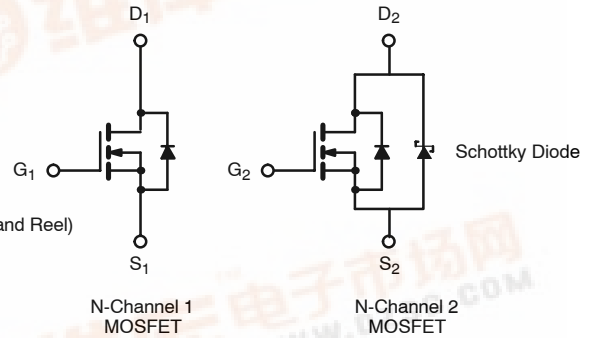
- TrenchFET® Power MOSFET
- 100% R<sub>g</sub> Tested

### APPLICATIONS

- DC/DC Converters
  - Game Stations
  - Notebook PC Logic



Ordering Information: Si4340DY  
Si4340DY-T1 (with Tape and Reel)



ABSOLUTE MAXIMUM RATINGS (T <sub>A</sub> = 25°C UNLESS OTHERWISE NOTED)							
Parameter	Symbol	Channel-1		Channel-2		Unit	
		10 secs	Steady State	10 secs	Steady State		
Drain-Source Voltage	V <sub>DS</sub>	20				V	
Gate-Source Voltage	V <sub>GS</sub>	± 20		± 16			
Continuous Drain Current (T <sub>J</sub> = 150°C) <sup>a</sup>	I <sub>D</sub>	T <sub>A</sub> = 25°C	9.6	7.3	13.5	9.5	A
		T <sub>A</sub> = 70°C	7.7	5.8	10.8	7.5	
Pulsed Drain Current	I <sub>DM</sub>	40		50		A	
Continuous Source Current (Diode Conduction) <sup>a</sup>	I <sub>S</sub>	1.8	1.04	2.73	1.30		
Maximum Power Dissipation <sup>a</sup>	P <sub>D</sub>	T <sub>A</sub> = 25°C	2.0	1.14	3.0	1.43	W
		T <sub>A</sub> = 70°C	1.28	0.73	1.9	0.91	
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	-55 to 150				°C	

THERMAL RESISTANCE RATINGS									
Parameter	Symbol	Channel-1		Channel-2		Schottky		Unit	
		Typ	Max	Typ	Max	Typ	Max		
Maximum Junction-to-Ambient <sup>a</sup>	t ≤ 10 sec	R <sub>thJA</sub>	53	62.5	35	42	40	48	°C/W
	Steady-State	R <sub>thJA</sub>	92	110	72	87	76	93	
Maximum Junction-to-Foot (Drain)	Steady-State	R <sub>thJF</sub>	35	42	18	23	21	25	

Notes:  
a. Surface Mounted on 1" x 1" FR4 Board.

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MOSFET SPECIFICATIONS (T <sub>J</sub> = 25 °C UNLESS OTHERWISE NOTED).							
Parameter	Symbol	Test Condition	Min	Typ <sup>a</sup>	Max	Unit	
<b>Static</b>							
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250 μA	Ch-1	0.8		2.00	V
			Ch-2	0.8		1.90	
Gate-Body Leakage	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = ±20 V	Ch-1			100	nA
		V <sub>DS</sub> = 0 V, V <sub>GS</sub> = ±12 V	Ch-2			100	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 20 V, V <sub>GS</sub> = 0 V	Ch-1			1	μA
			Ch-2			100	
		V <sub>DS</sub> = 20 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 85 °C	Ch-1			15	
			Ch-2			4000	
On-State Drain Current <sup>b</sup>	I <sub>D(on)</sub>	V <sub>DS</sub> = 5 V, V <sub>GS</sub> = 10 V	Ch-1	20		A	
Ch-2	30						
Drain-Source On-State Resistance <sup>b</sup>	r <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 9.6 A	Ch-1		0.0095	0.012	Ω
		V <sub>GS</sub> = 10 V, I <sub>D</sub> = 13.5 A	Ch-2		0.007	0.010	
		V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 7.8 A	Ch-1		0.0135	0.0175	
		V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 12.8 A	Ch-2		0.0085	0.0115	
Forward Transconductance <sup>b</sup>	g <sub>fs</sub>	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 9.6 A	Ch-1		25	S	
		V <sub>DS</sub> = 15 V, I <sub>D</sub> = 13.5 A	Ch-2		38		
Diode Forward Voltage <sup>b</sup>	V <sub>SD</sub>	I <sub>S</sub> = 1.8 A, V <sub>GS</sub> = 0 V	Ch-1		0.74	1.1	V
		I <sub>S</sub> = 2.73 A, V <sub>GS</sub> = 0 V	Ch-2		0.485	0.53	
<b>Dynamic<sup>a</sup></b>							
Total Gate Charge	Q <sub>g</sub>	Channel-1 V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 9.6 A Channel-2 V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = -13.5 A	Ch-1		10	15	nC
Gate-Source Charge	Q <sub>gs</sub>		Ch-2		17	25	
			Ch-1		3.3		
Gate-Drain Charge	Q <sub>gd</sub>		Ch-2		4.5		
		Ch-1		3.1			
Gate Resistance	R <sub>g</sub>	f = 1 MHz	Ch-1	0.45	0.9	1.35	Ω
			Ch-2	0.7	1.4	2.1	
Turn-On Delay Time	t <sub>d(on)</sub>	Channel-1 V <sub>DD</sub> = 01 V, R <sub>L</sub> = 10 Ω I <sub>D</sub> ≅ 1 A, V <sub>GEN</sub> = 10 V, R <sub>G</sub> = 6 Ω Channel-2 V <sub>DD</sub> = 01 V, R <sub>L</sub> = 15 Ω I <sub>D</sub> ≅ 1 A, V <sub>GEN</sub> = 10 V, R <sub>G</sub> = 6 Ω	Ch-1		15	25	ns
Rise Time	t <sub>r</sub>		Ch-2		24	35	
			Ch-1		16	25	
Turn-Off Delay Time	t <sub>d(off)</sub>		Ch-2		22	35	
			Ch-1		42	65	
Fall Time	t <sub>f</sub>		Ch-2		68	100	
		Ch-1		16	25		
Source-Drain Reverse Recovery Time	t <sub>rr</sub>	I <sub>F</sub> = 1.8 A, di/dt = 100 A/μs	Ch-1		35	60	
		I <sub>F</sub> = 2.73 A, di/dt = 100 μA/μs	Ch-2		38	65	

**Notes**

- a. Guaranteed by design, not subject to production testing.
- b. Pulse test; pulse width ≤ 300 μs, duty cycle ≤ 2%.

SCHOTTKY SPECIFICATIONS (T <sub>J</sub> = 25 °C UNLESS OTHERWISE NOTED)							
Parameter	Symbol	Test Condition	Min	Typ	Max	Unit	
Forward Voltage Drop	V <sub>F</sub>	I <sub>F</sub> = 3 A		0.485	0.53	V	
		I <sub>F</sub> = 3 A, T <sub>J</sub> = 125 °C		0.42	0.42		
Maximum Reverse Leakage Current	I <sub>rm</sub>	V <sub>r</sub> = 20 V		0.008	0.100	mA	
		V <sub>r</sub> = 20 V, T <sub>J</sub> = 75 °C		0.4	5		
		V <sub>r</sub> = -20 V, T <sub>J</sub> = 125 °C		6.5	20		
Junction Capacitance	C <sub>T</sub>	V <sub>r</sub> = 15 V		102		pF	



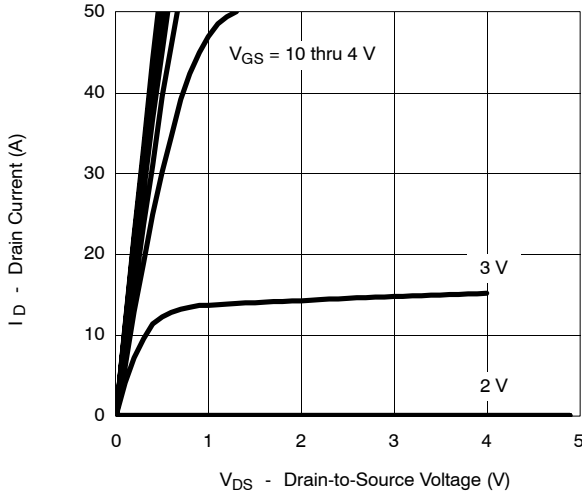
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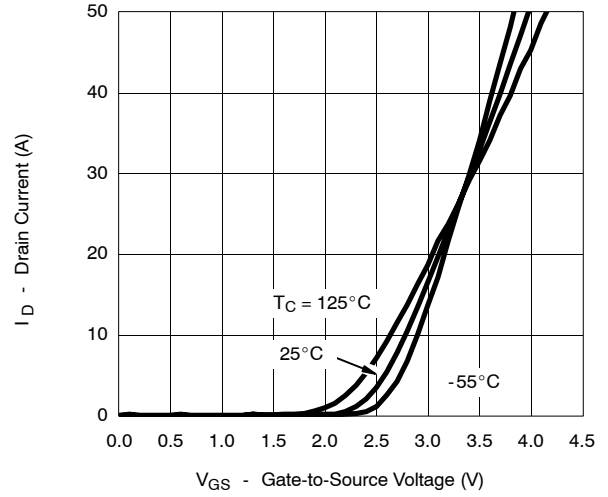
**TYPICAL CHARACTERISTICS (25°C UNLESS NOTED)**

**CHANNEL-1**

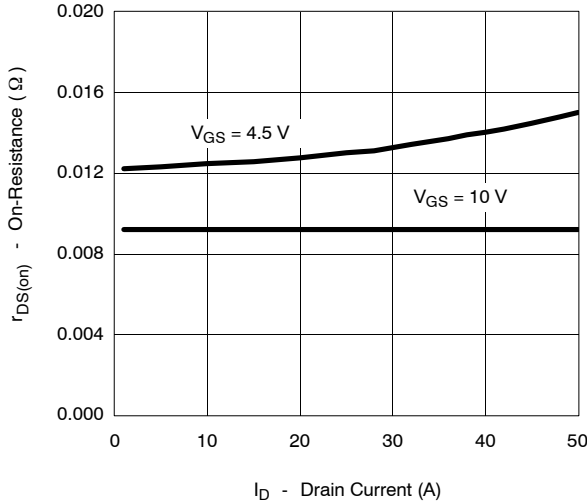
**Output Characteristics**



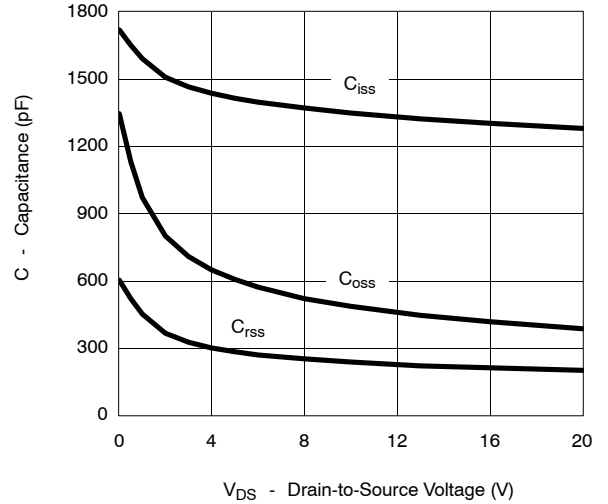
**Transfer Characteristics**



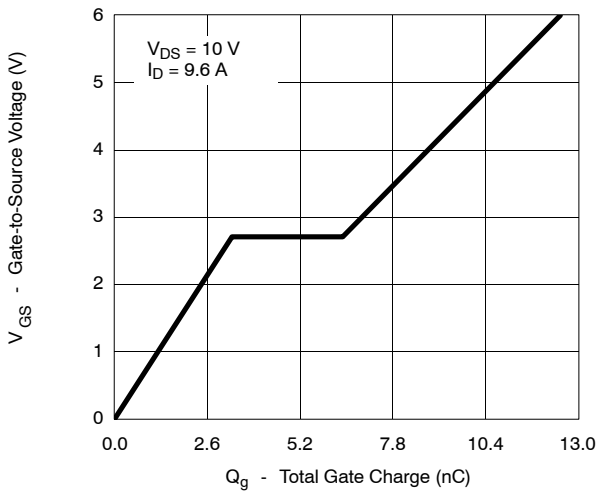
**On-Resistance vs. Drain Current**



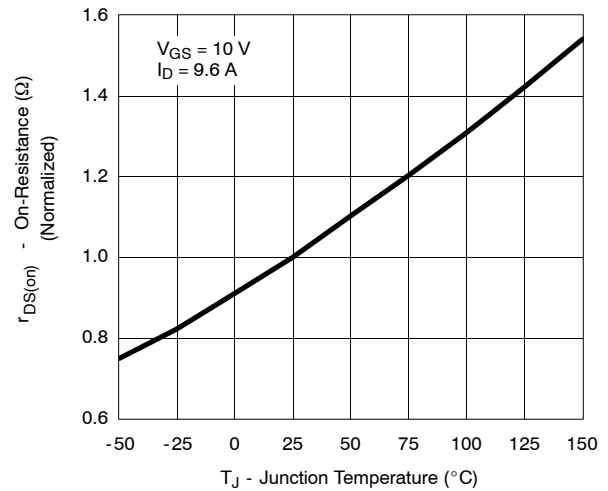
**Capacitance**



**Gate Charge**



**On-Resistance vs. Junction Temperature**

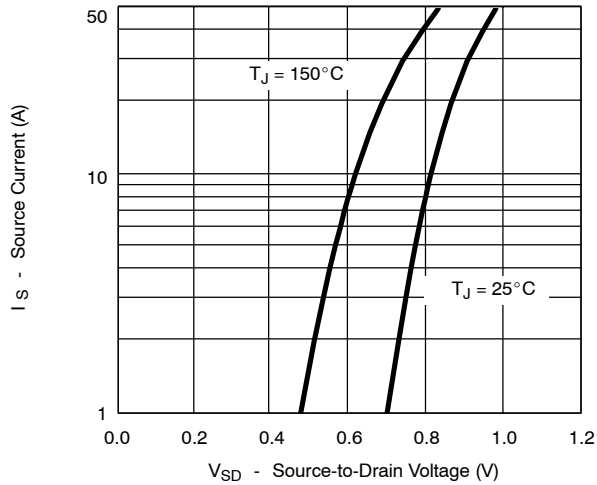




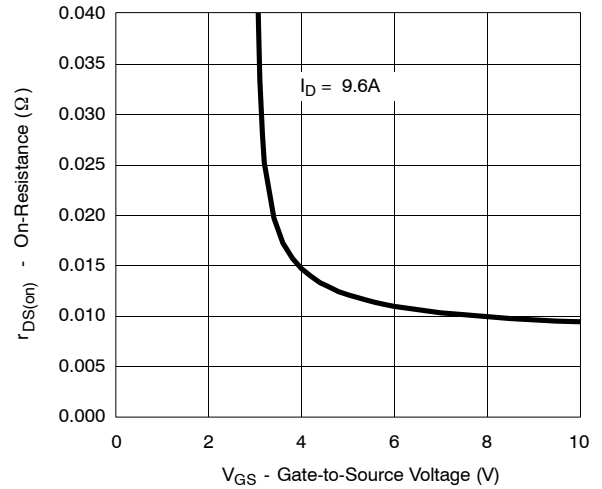
### TYPICAL CHARACTERISTICS (25 °C UNLESS NOTED)

### CHANNEL-1

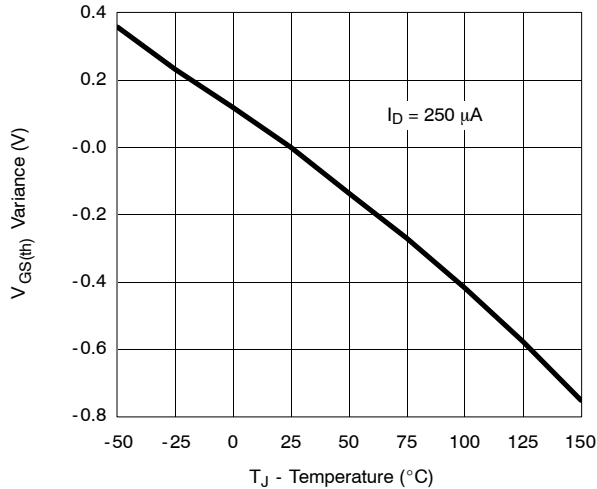
Source-Drain Diode Forward Voltage



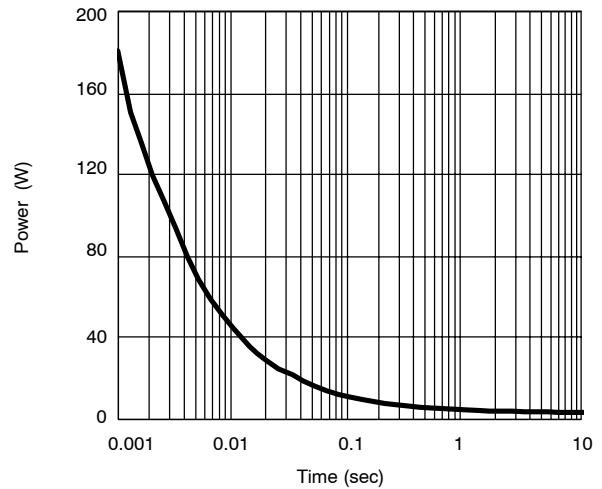
On-Resistance vs. Gate-to-Source Voltage



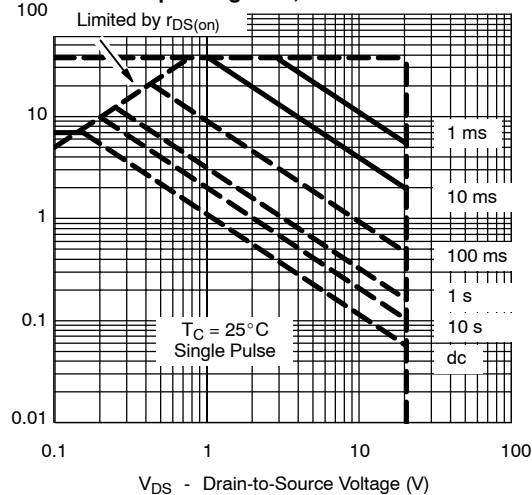
Threshold Voltage



Single Pulse Power



Safe Operating Area, Junction-to-Case





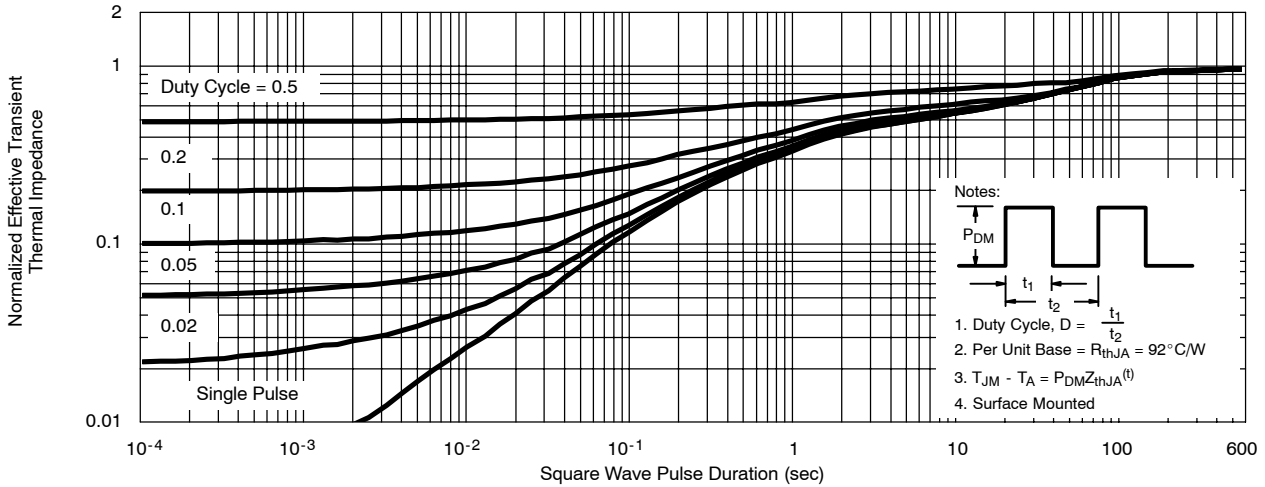
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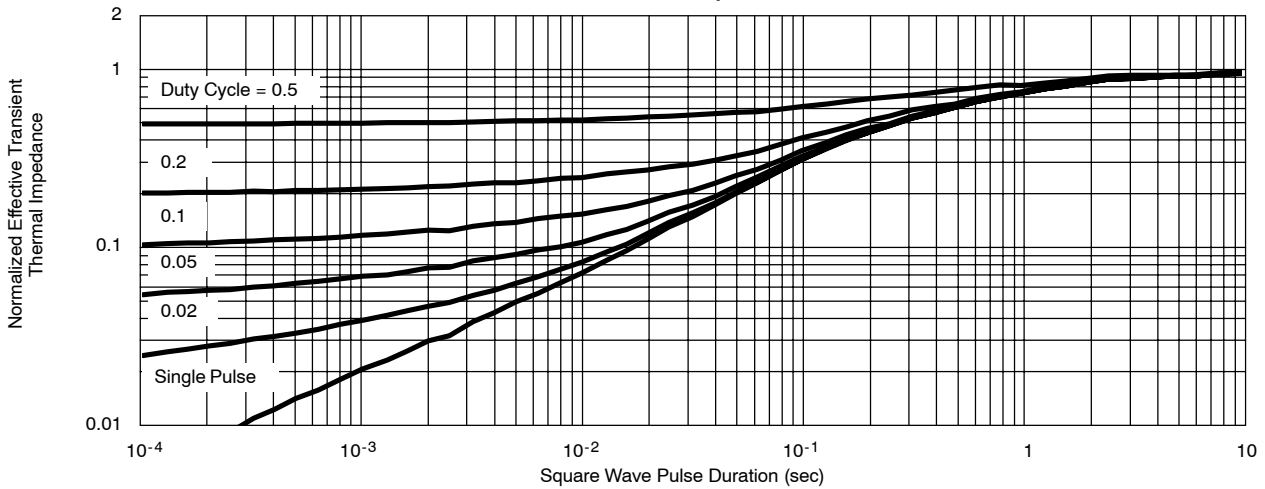
TYPICAL CHARACTERISTICS (25°C UNLESS NOTED)

CHANNEL-1

Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot



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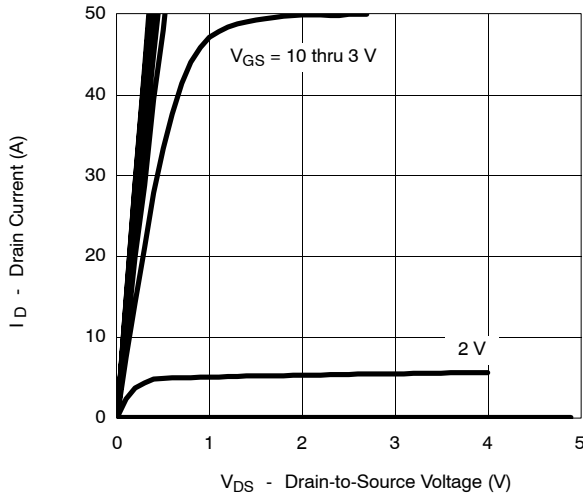
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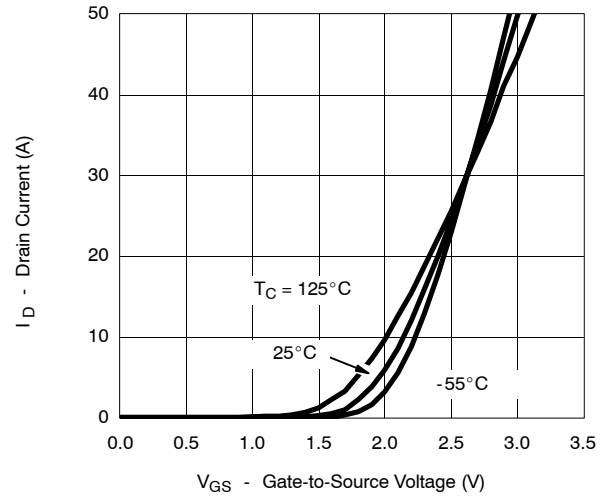
## TYPICAL CHARACTERISTICS (25 °C UNLESS NOTED)

## CHANNEL-2

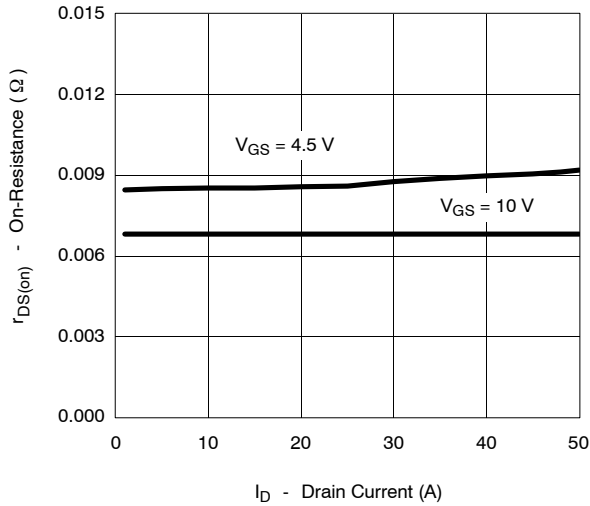
Output Characteristics



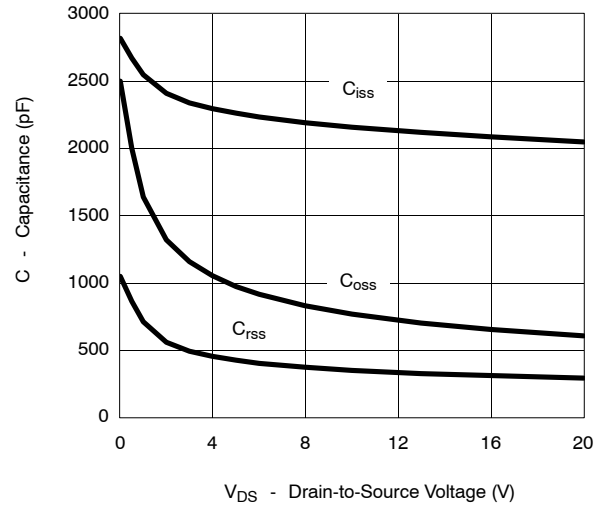
Transfer Characteristics



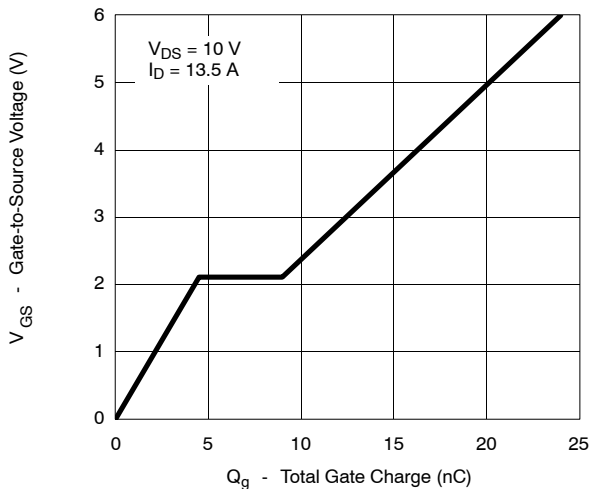
On-Resistance vs. Drain Current



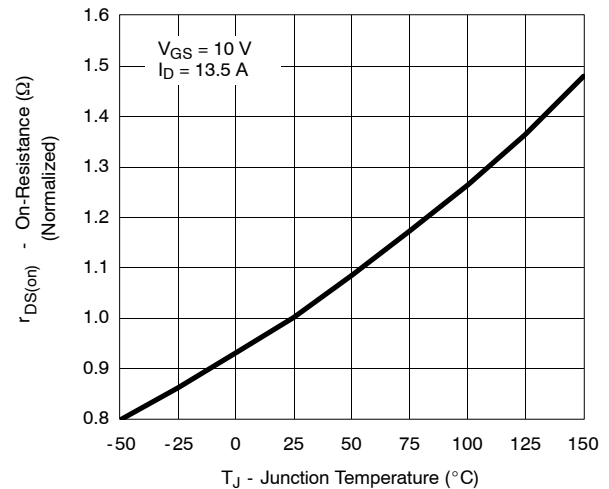
Capacitance



Gate Charge



On-Resistance vs. Junction Temperature





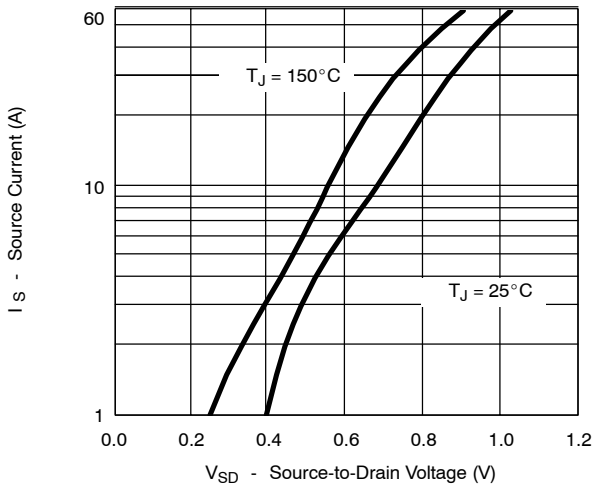
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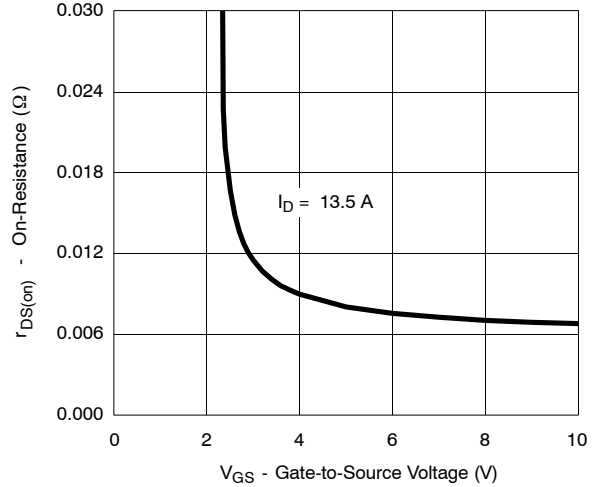
**TYPICAL CHARACTERISTICS (25°C UNLESS NOTED)**

**CHANNEL-2**

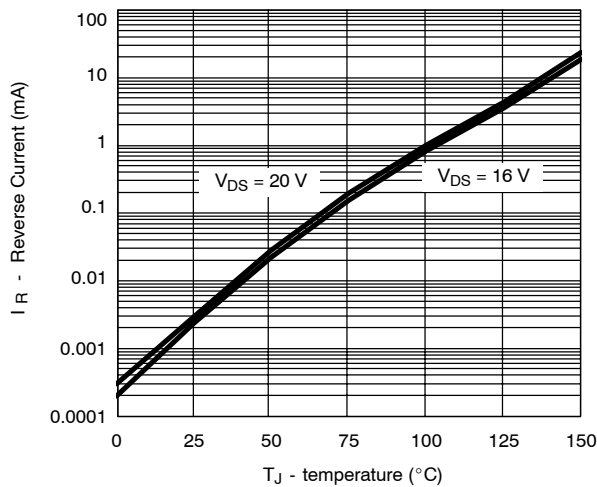
Source-Drain Diode Forward Voltage



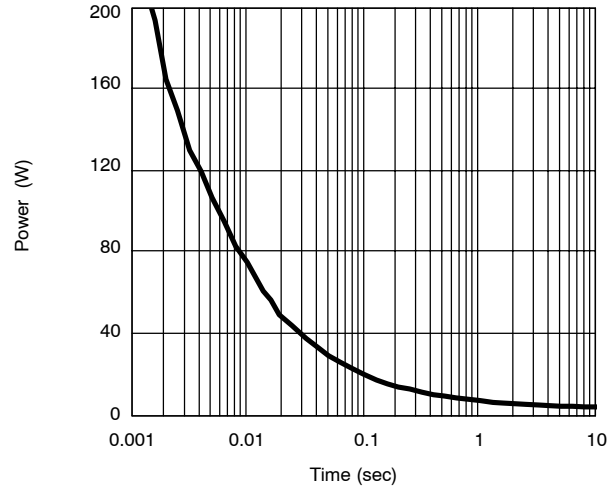
On-Resistance vs. Gate-to-Source Voltage



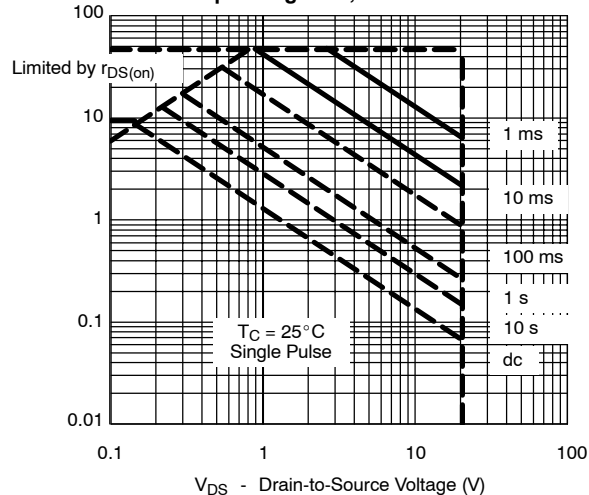
Reverse Current vs. Junction Temperature



Single Pulse Power



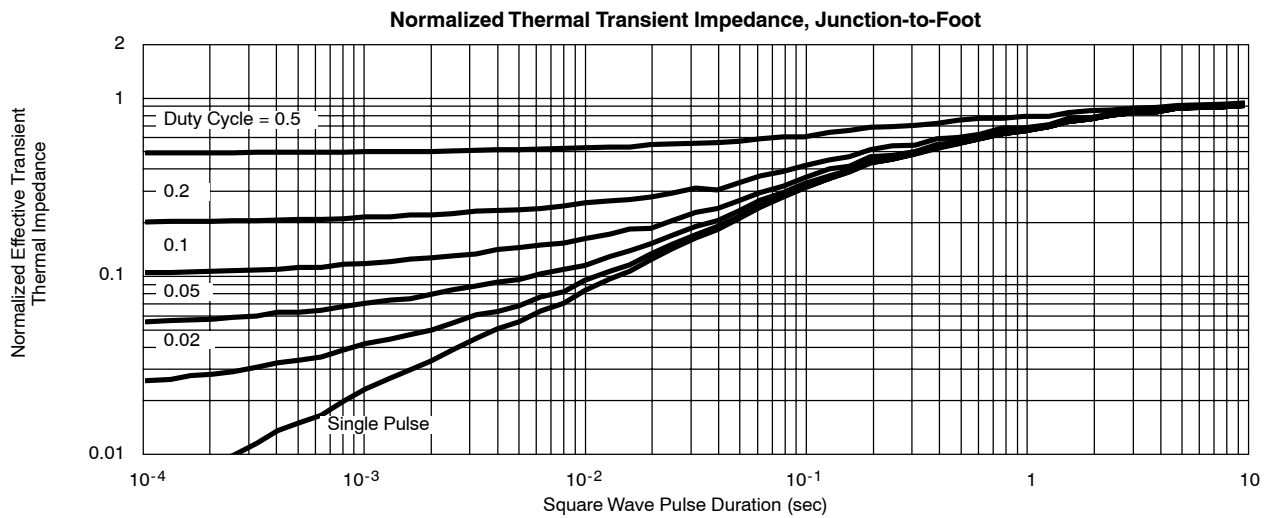
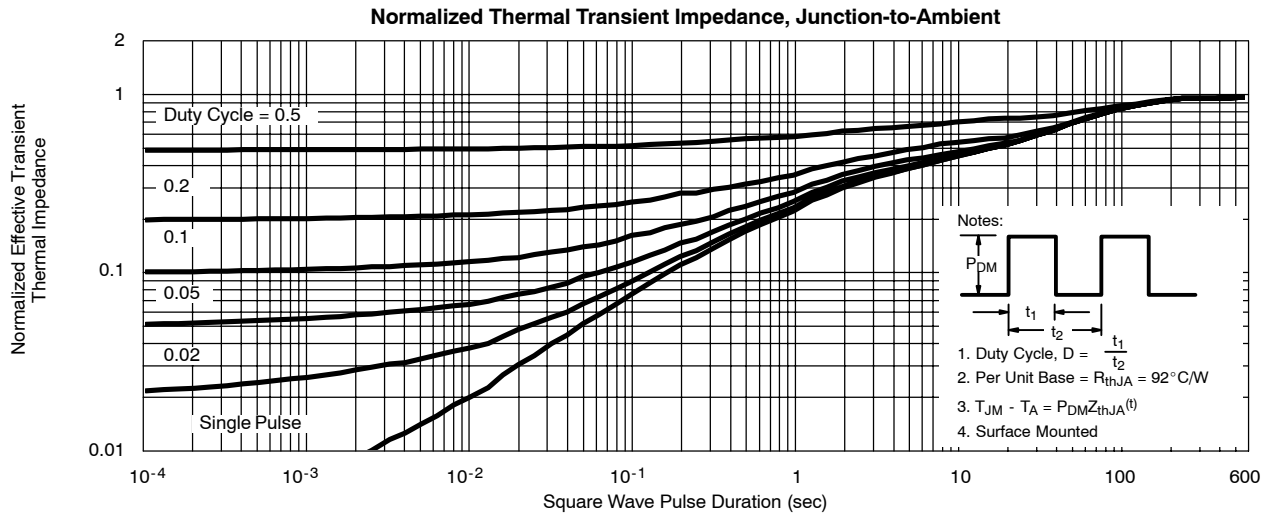
Safe Operating Area, Junction-to-Case





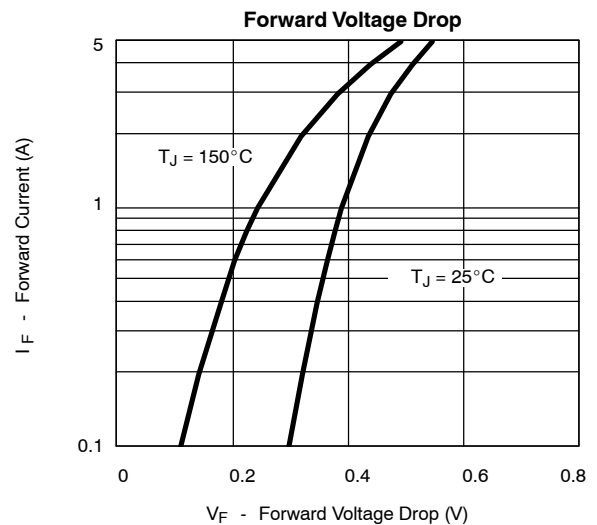
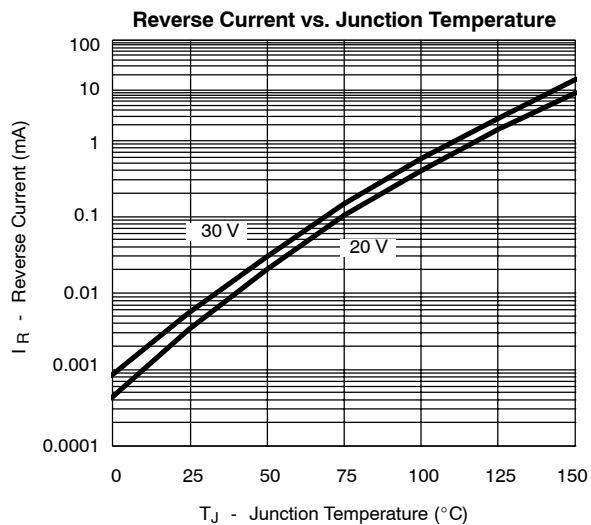
**TYPICAL CHARACTERISTICS (25°C UNLESS NOTED)**

**CHANNEL-2**



**TYPICAL CHARACTERISTICS (25°C UNLESS NOTED)**

**SCHOTTKY**







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TYPICAL CHARACTERISTICS (25°C UNLESS NOTED)

SCHOTTKY

